Search Notes



| Application/Control No. | |
|-------------------------|--|
| | |

10519988

Applicant(s)/Patent Under Reexamination SCHARNWEBER ET AL.

Art Unit

Examiner
Young J Kim

1637

SEARCHED

Class Subclass Date Examiner

| SEARCH NOTES | | | | |
|--|------------|----------|--|--|
| Search Notes | Date | Examiner | | |
| Patent Databases (USPT, USPGP, EPO, JPO, DERWENT, IBM-TDB) | 2/27/2008 | YJK | | |
| see enclosed for text-search strategy | 2/27/2008 | YJK | | |
| Patent Databases (USPT, USPGP, EPO, JPO, DERWENT, IBM-TDB) | 12/10/2008 | /YJK/ | | |
| see enclosed for text-search strategy | 12/10/2008 | /YJK/ | | |
| Updated - see enclosed for text-search strategy | 6/11/2009 | /YJK/ | | |

| INTERFERENCE SEARCH | | | | |
|---------------------|---|-----------|----------|--|
| Class | Subclass | Date | Examiner | |
| | Interference search history - see print out | 6/11/2009 | /YJK/ | |

/Young J Kim/ Primary Examiner.Art Unit 1637

U.S. Patent and Trademark Office Part of Paper No.: 20090611